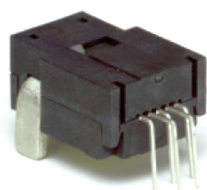


Magnetic Proportion System / Compact size and High-speed response. $V_{CC} = +5.0V$

LA03P Series



RoHS

ABSOLUTE MAXIMUM RATINGS

Parameters	Symbol	Unit	Value	Comment
Supply voltage	V_{DD}	V	6.5	
Jumper temperature	—	°C	120	
Output current	I_{out}	mA	± 1	Recommend ; $< \pm 0.5mA$
ESD rating (HBM: Human Body Model)	—	kV	2	$C=100pF$, $R=1.5k\Omega$

ISOLATION CHARACTERISTICS

Parameters	Symbol	Unit	Value	Comment
Insulation voltage	V_d	V	$\geq AC3000V$, 50/60Hz, for 1minute (Sensing current 0.5mA)	Primary \leftrightarrow Secondary
Impulse withstand voltage	V_w	kV	6	Primary \leftrightarrow Secondary Input waveform : • Front time 1.2 μs • Time to half value 50 μs • single
Clearance distance	d_{Ci}	mm	13.3	Primary \leftrightarrow Secondary
Creepage distance	d_{Cp}	mm	13.3	Primary \leftrightarrow Secondary
Case material	—	—	UL94 V-0	
Comparative Tracking Index : (CTI)	CTI	V	150	

ENVIRONMENTAL AND MECHANICAL CHARACTERISTICS

Parameters	Symbol	Unit	Value			Comment
			MIN	TYP	MAX	
Ambient operating temperature	T_a	°C	- 40		+ 110	
Ambient storage temperature	T_s	°C	- 40		+ 150	
Mass	m	g		5.5		
Internal magnetic core	—	—	Ferrite			

SPECIFICATIONS

$T_a = +25^\circ C$, $V_{DD} = +5V$, $R_L \geq 10M\Omega$

Parameters		Symbol	Unit	Value			Comment
				MIN	TYP	MAX	
Measurement current range	LA03P021S05	I_f	A	- 21		21	
	LA03P035S05			- 35		35	
	LA03P054S05			- 54		54	
	LA03P085S05			- 85		85	

SPECIFICATIONS

Ta=+25°C, V_{DD}=+5V, RL≥10MΩ

Parameters		Symbol	Unit	Value			Comment
				MIN	TYP	MAX	
Maximum primary current (RMS)		I _{p (RMS)} max	A			50	* 1
Supply Voltage		V _{DD}	V	4.5	5.0	5.5	
Number of primary turns		N _p	T	1			
Primary Jumper resistance		R _p	m Ω		0.1		
Current consumption (at I _f)		I _{DD}	mA			11	
Offset voltage (at I _f =0A)	—	V _{of}	V	2.480	2.500	2.520	At factory shipment
	LA03P021S05			(2.350)	2.500	(2.650)	Reference value after the flow soldering and over the lifetime of this product.
	LA03P035S05			(2.400)	2.500	(2.600)	
	LA03P054S05			(2.425)	2.500	(2.575)	
	LA03P085S05			(2.445)	2.500	(2.555)	
Temperature drift of offset voltage (at Ta= − 40 ~+ 110°C, Variation from V _{of} (Ta=35°C), I _p =0A)	LA03P021S05	TCV _{of}	mV		± 23.0		
	LA03P035S05				± 12.0		
	LA03P054S05				± 8.0		
	LA03P085S05				± 6.0		
Sensitivity	LA03P021S05	G	mV/A	98.0	100.0	102.0	
	LA03P035S05			58.8	60.0	61.2	
	LA03P054S05			39.2	40.0	40.8	
	LA03P085S05			24.4	25.0	25.6	
Temperature coefficient 1 of Sensitivity (at Ta= − 40 ~+ 110°C, Variation ratio to G (Ta=35°C))		TCG1	%		± 0.5		
Output Linearity (at 0... I _f)		ε _L	%F.S.	− 1		1	
Output noise voltage		V _{NRMS}	mVrms		1.7		
Ratiometric error of sensitivity		V _{G-R}	%	− 1		1	
Ratiometric error of offset voltage	LA03P021S05	V _{of-R}	%F.S.	− 0.7		0.7	
	LA03P035S05			− 0.5		0.5	
	LA03P054S05			− 0.5		0.5	
	LA03P085S05			− 0.5		0.5	
Response time 1 (at 90% of I _f)		tr	μs		1		CL=100pF
Frequency bandwidth (− 3dB)		BW	kHz		300		CL=100pF

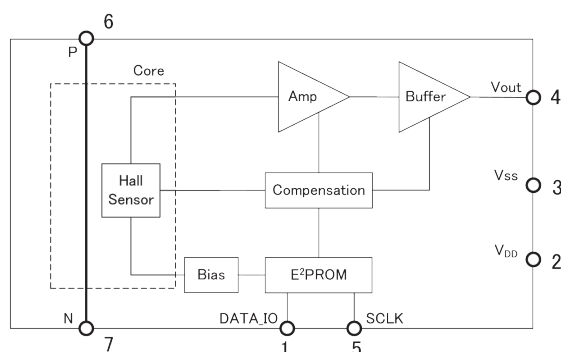
* 1 When I_{p(RMS)}max is bigger than the value of I_f, I_{p(RMS)}max restricts it to the value of I_f.

STANDARDS

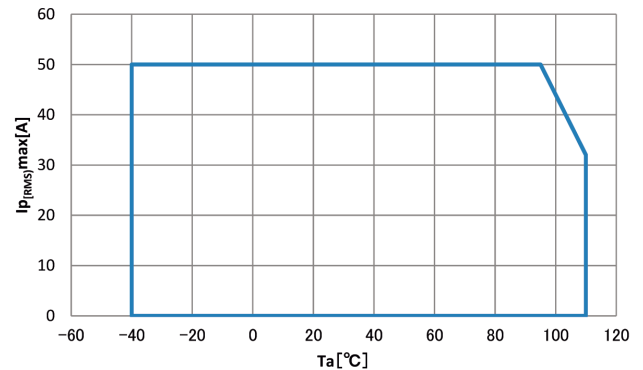
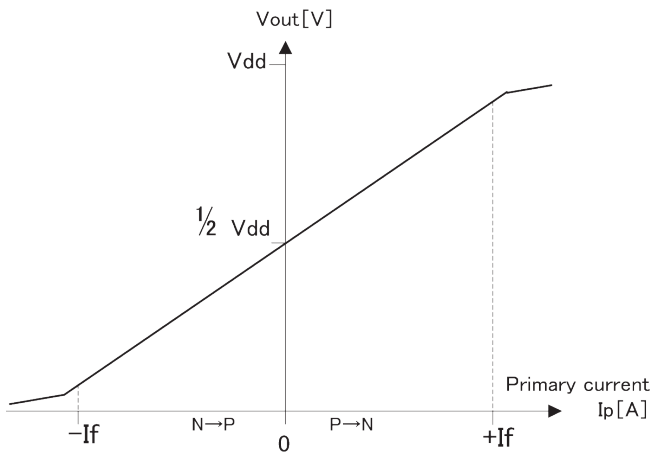
IEC60950 , UL508 , CSA C22.2 No. 14

※ Please refer to the another sheet about conditions of UL Recognition.

FUNCTIONAL BLOCK DIAGRAM

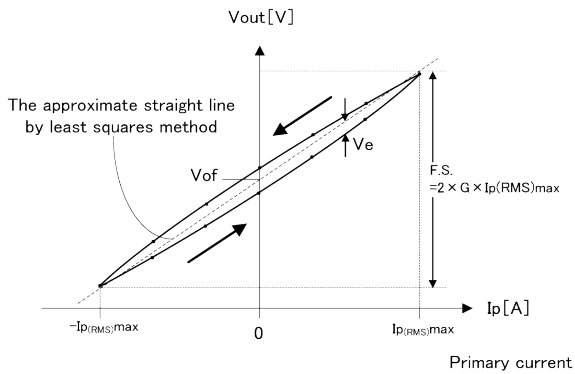


CHARACTERISTIC CURVE (TYP) AND PRIMARY CURRENT DERATING CURVE



Conditions : Mounted on the test board complying with the EIA/JEDEC Standards (EIA/JESD51.)

CHARACTERISTICS DEFINITIONS



- When $I_{p(RMS)max}$ is bigger than the value of I_f , $I_{p(RMS)max}$ restricts it to the value of I_f .

- Sensitivity G [mV/A], Offset voltage V_{of} [V]
Sensitivity (G) is defined as slope of the approximate straight line by least squares method, using the data of the output voltage (V_{out}) when sweeping the measured current I_p at rated current range.

Also Offset voltage (V_{of}) is defined as the intercept of the approximate straight line.

- Output linearity ϵ_L [%]

Output linearity (ϵ_L) is defined as the ratio of maximum error voltage (V_e) to the full scale (F.S.), where V_d is maximum difference between the Output voltage (V_{out}) and the approximate straight line calculated in the sensitivity and offset voltage definition;

$$\epsilon_L = V_e / F.S. \times 100$$

- Ratiometric error of sensitivity V_{G-R} [%], ratiometric error of Offset voltage V_{of-R} [%]

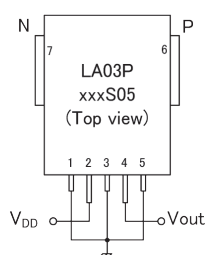
Output of LA03P Series is ratiometric.

Sensitivity (G) and Offset voltage (V_{of}) are proportional to Supply voltage (V_{DD}).

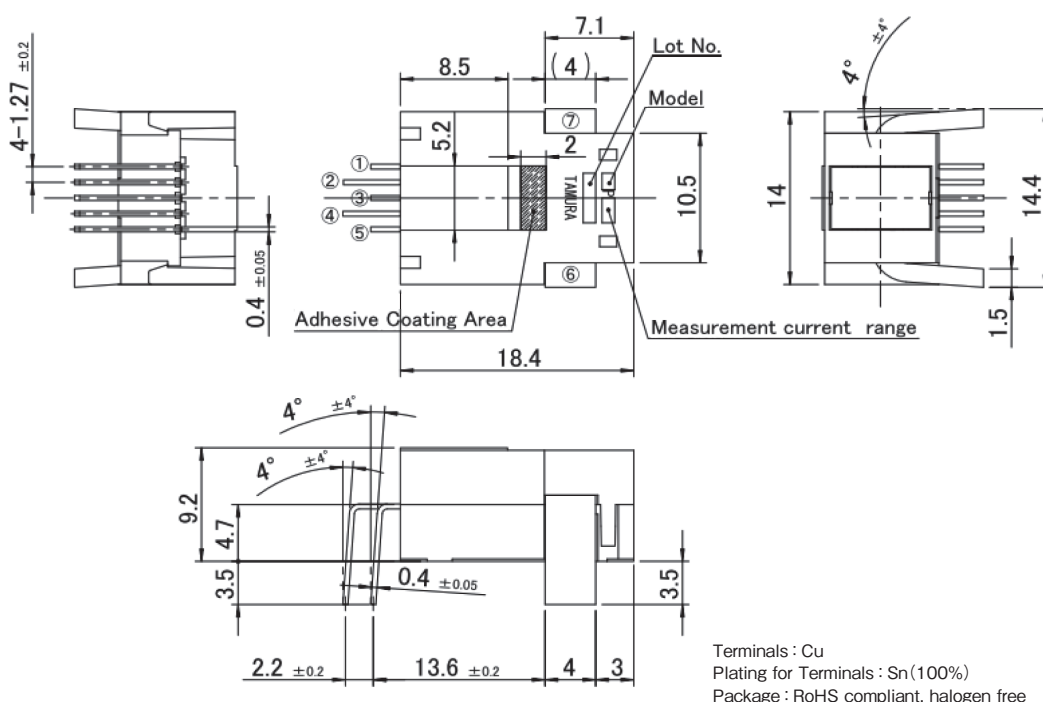
- Ratiometric error is defined as follows in the supply voltage range ($4.5V < V_{DD1} < 5.5V$);

$$V_{G-R} = 100 \times [(G(V_{DD}=V_{DD1}) / G(V_{DD}=5V)) - (V_{DD1} / 5)] / (V_{DD1} / 5)$$

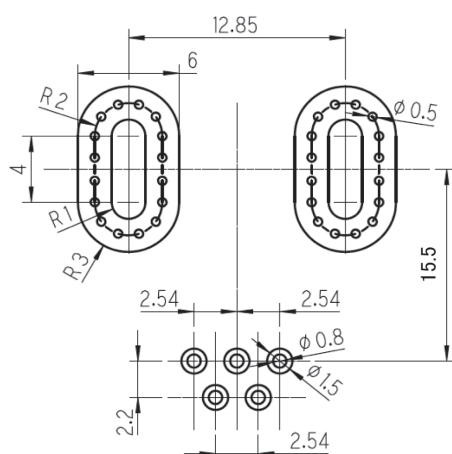
$$V_{of-R} = 100 \times [V_{of}(V_{DD}=V_{DD1}) - V_{of}(V_{DD}=5V) \times (V_{DD1} / 5)] / F.S.$$



Terminal number	
① DATA_IO	Test pin (connect to GND)
② V _{DD}	Power supply (5V)
③ V _{SS}	GND (0V)
④ V _{out}	Analog output
⑤ SCLK	Test pin (connect to GND)
⑥ P	Input
⑦ N	Output

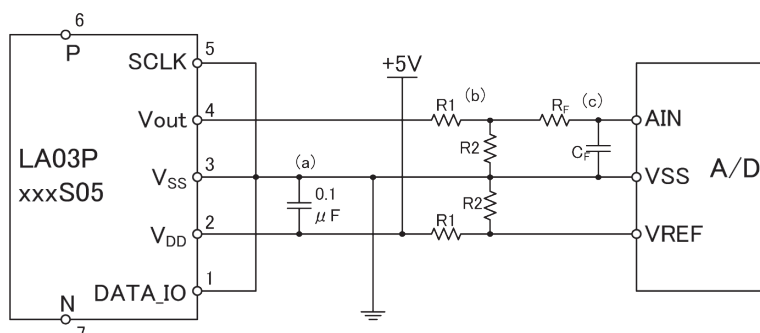


Note1) The tolerances of dimensions without any mention are ± 0.1 mm.



Note) If 2 or more trace layers are used as the current path, please make enough number of through-holes to flow current between the trace layers.

TYPICAL APPLICATION



- (a) Please be placed the bypass capacitor $0.1 \mu F$ as close as possible to the V_{DD} and V_{SS} pins of LA03P Series.
- (b) LA03P Series have a ratiometric output. When received output by the A / D converter, it is possible to reduce the A / D conversion error due to supply voltage fluctuations by setting a common voltage level of the A / D converter and supply voltage. The resistive divider with $R1$ and $R2$ is required, if the reference voltage of the A / D converter is lower than + 5V.
- (c) If necessary, please insert a low-pass filter to V_{out} .

TYPE DESIGNATION

LA03 P * * * S 05

① ② ③ ④ ⑤

- ① Model (4 figures)
LA03 : Series
- ② Mounting configuration (1 figure)
P : PCB Mounting type
- ③ Measurement current range (3 figures)
Ex) 035 : 35A 085 : 85A
- ④ Control power supply type (1 figure)
S : Single supply
- ⑤ Power supply voltage (2 digits)

RELIABILITY TEST

No.	Item	Test Conditions	n	Test Time
1	High Temp. High Humidity Bias Test	【JEITA EIAJ ED-4701 102】 $T_a=85^{\circ}\text{C}$, 85%RH, continuous operation	22	1000h
2	High Temperature Bias Test	【JEITA EIAJ ED-4701 101】 $T_a=125^{\circ}\text{C}$, continuous operation	22	1000h
3	High Temperature Storage Test	【JEITA EIAJ ED-4701 201】 $T_a=150^{\circ}\text{C}$	22	1000h
4	Low Temperature Storage Test	【JEITA EIAJ ED-4701 202】 $T_a=-55^{\circ}\text{C}$	22	1000h
5	Heat Cycle Test	【JEITA EIAJ ED-4701 105】 $-65^{\circ}\text{C}(30\text{min}) \leftrightarrow 150^{\circ}\text{C}(30\text{min})$ Tested in vapor phase	22	500 cycles
6	Vibration Test	【JEITA EIAJ ED-4701 403】 Vibration frequency: 10~55Hz(1 min.) Vibration amplitude: 1.5mm(x,y,z directions)	5	2h for each direction

Tested samples are pretreated as below before each reliability test:

Desiccation : $125^{\circ}\text{C} / 24\text{h} \rightarrow$ Moisture Absorption : $85^{\circ}\text{C} / 85\%\text{RH} / 168\text{h} \rightarrow$ Flow : 1 time (260°C , 10s)

Criterion for determining

Products whose drifts before and after the reliability tests do not exceed the values below are considered to be in spec.

Sensitivity G ($T_a=25^{\circ}\text{C}$) : Within $\pm 1.5\%$ (All model)

Offset Voltage V_{of} ($T_a=25^{\circ}\text{C}$) : Within $\pm 150\text{mV}$ (LA03P021S05), Within $\pm 100\text{mV}$ (Other model)

Output Linearity ε_L ($T_a=25^{\circ}\text{C}$) : Within $\pm 1\%$ (All model)

Important Notice

1. The content of this information is subject to change without prior notice for the purpose of improvements, etc. Ensure that you are in possession of the most up-to-date information when using this product.
2. This product is intended to be used in general electronics applications (electric home appliances, business equipment, information equipment, communication terminal equipment, measuring devices, industrial equipment, and so on). This product is neither intended nor warranted for use in following equipment or devices:

Special application (such as for medical devices, transportation equipment, traffic signal control equipment, fire and crime prevention equipment, aeronautics and space devices, nuclear power control, fuel control, in-vehicle equipment, safety devices, and so on) in which extremely high quality and high reliability is required, or if the malfunction or failures of product could be cause loss of human life, bodily injury.

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3. Tamura Corporation constantly strives to improve quality and reliability, but malfunction or failures are bound to occur with some probability in current sensor. To ensure that failures do not cause accidents resulting in injury or death, fire accidents, social damage, and so on, users are to thoroughly verify the safety of their designs in devices and/or systems.
4. The operation examples and circuit examples shown in this information are for reference purposes only, and Tamura Corporation disclaims all responsibility for any violations of industrial property rights, intellectual property rights and any other rights owned by Tamura Corporation or third parties that these may entail.
5. The circuit examples and part constants listed in these specifications are provided as reference for the verification of characteristics. The user is to perform design, verification, and judgment under his or her own responsibility, taking into account the various conditions.
6. The products are designed for use in environments where consumer electronics are commonly used. It is not designed for use in special environments such as listed below, and if such use is considered, the user is to perform thorough safety and reliability checks under his/her responsibility.
7. This product is not designed to resist radiation.
 - *Use in liquids such as water, oil, chemical solutions, or organic solvents, and use in locations where the product will be exposed to such liquids.*
 - *Use that involves exposure to direct sunlight, outdoor exposure, or dusty conditions.*
 - *Use in locations where corrosive gases such as sea winds, Cl₂, H₂S, NH₃, SO₂, or NO₂, are present. (Some product improves durability)*
 - *Use in environments with strong static electricity or electromagnetic radiation.*
 - *Use that involves placing inflammable material next to the product.*
 - *Use of this product either sealed with a resin filling or coated with resin.*
 - *Use of water or a water soluble detergent for flux cleaning.*
 - *Use in locations where condensation is liable to occur.*
8. Do not use or otherwise make available the TAMURA products or the technology described in this document for any military purposes, including without limitation, for the design, development, use, stockpiling or manufacturing of mass destruction weapons (e.g. nuclear, chemical, or biological weapons or missile technology products). When exporting and re-exporting the products or technology described in this document, you should comply with the applicable export control laws and regulations and follow the procedures required by such laws and regulations including, without limitation, Japan -Foreign Exchange and Foreign Trade Control Law and U.S.-Export Administration Regulations. The TAMURA products and related technology should not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations.
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Application notes

<General Considerations>

1. The sensor uses polar electronic components. When the polarity of the power supply is mistaken, the sensor is damaged.
2. Static electricity or excessive voltage can increase an offset voltage in the Hall element, and cause offset voltage to change. Please exercise care in handling and application.
3. In order to prevent the influence of noise, the use of twisted cable or shielded cable for the output line is recommended
4. If using this device within a magnetic field generated by other devices, the specified accuracy may not be obtainable.
5. Our products (several models are excluded) are adjusted with the trimming method by the measurement condition (Load resistance, Power supply voltage) of specification sheets. Therefore, characteristics (Offset, Output, etc.) and its deviation may be changed in different circuit conditions from the measurement condition. All change characteristic items are not indicated on specification sheets.
6. The performance of current sensors with through-hole (aperture) is dependent on the position of the primary conductor. Tamura specifications are based on a primary conductor completely filling the through-hole (aperture) area.
7. The current sensor rated current in DC Amps.
8. Please use mating connector with equivalent terminal plating material to insure proper operation and avoid possibility of 'galvanic corrosion' .
9. Please do not store in high-temperature and high-humidity storage environment. Please use it after confirming soldering when it is kept for six months or more. (product soldered with substrate)
10. We recommend performing a zero offset adjustment by measuring the offset voltage at startup. In continuously operation for a few months, or at change of ambient temperature or humidity is large, we recommend regularly performing a zero offset adjustment at being idling (it is clear that the current is not apply) .

<Open loop>

1. High frequency primary current may result in excessive heating in iron magnetic core and cause damage to internal circuitry; for high frequency applications select current sensor with ferrite core material.
2. If the measured current exceeds the rated current, magnetic core saturation will occur and the output voltage signal will not be linearly proportional to the measured current.

<Closed Loop>

1. For closed loop current sensors please insure the power supply voltage is balanced, symmetrical, and, applied simultaneously to avoid potential increase in DC offset error.
2. Maximum rated current measurement duration is timedependent. Maximum rated current applied in excess of the time limit can result in damage to internal electronic circuitry; please consult Tamura for assistance.
3. When using a measurement resistor to convert current output to voltage output select a resistor with stable temperature characteristic to insure accuracy of the output voltage.
4. Compensation current supplied to the secondary winding varies in proportion to the measured current based on the conversion ratio. (If/ KN ; KN = secondary turns) Please insure the PSU has required current capacity to supply compensation current to the secondary winding.

<Flux-Gate>

1. Compensation current supplied to the secondary winding varies in proportion to the measured current. Please insure the PSU has required current capacity to supply compensation current to the secondary winding.
2. There is 450kHz ripple voltage present on the output and reference output voltage signals . An external capacitor maybe added if necessary.

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